

**Table 1: General Features**

TYPE	V <sub>DSS</sub>	R <sub>D(on)</sub>	I <sub>D</sub>
STD17NF03L	30 V	< 0.05 Ω	17 A
STD17NF03L-1	30 V	< 0.05 Ω	17 A

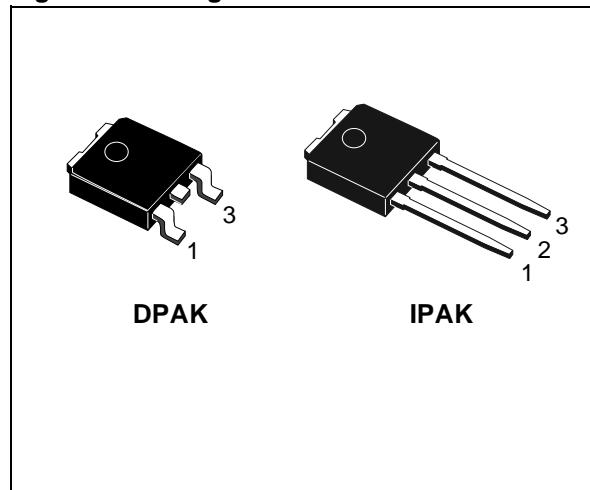
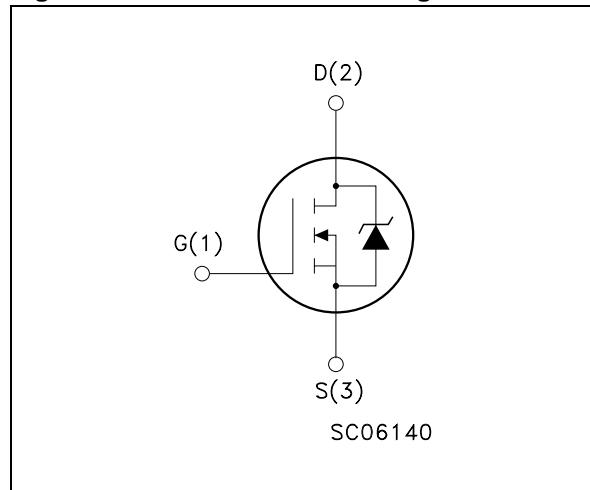
- TYPICAL R<sub>D(on)</sub> = 0.038Ω
- EXCEPTIONAL dv/dt CAPABILITY
- LOW GATE CHARGE AT 100°C
- APPLICATION ORIENTED CHARACTERIZATION
- 100% AVALANCHE TESTED

### DESCRIPTION

This MOSFET is the latest development of STMicroelectronics unique "Single Feature Size™" strip-based process. The resulting transistor shows extremely high packing density for low on-resistance, rugged avalanche characteristics and less critical alignment steps therefore a remarkable manufacturing reproducibility.

### APPLICATIONS

- DC-DC & DC-AC CONVERTERS
- MOTOR CONTROL, AUDIO AMPLIFIERS
- HIGH CURRENT, HIGH SPEED SWITCHING
- SOLENOID AND RELAY DRIVERS
- AUTOMOTIVE ENVIRONMENT

**Figure 1: Package**

**Figure 2: Internal Schematic Diagram**

**Table 2: Order Codes**

SALES TYPE	MARKING	PACKAGE	PACKAGING
STD17NF03LT4	D17NF03L@	DPAK	TAPE & REEL
STD17NF03L-1	D17NF03L@	IPAK	TUBE

**Table 3: Absolute Maximum ratings**

Symbol	Parameter	Value	Unit
V <sub>DS</sub>	Drain-source Voltage ( $V_{GS} = 0$ )	30	V
V <sub>DGR</sub>	Drain-gate Voltage ( $R_{GS} = 20 \text{ k}\Omega$ )	30	V
V <sub>GS</sub>	Gate- source Voltage	±16	V
I <sub>D</sub>	Drain Current (continuous) at $T_C = 25^\circ\text{C}$	17	A
I <sub>D</sub>	Drain Current (continuous) at $T_C = 100^\circ\text{C}$	12	A
I <sub>DM</sub> (•)	Drain Current (pulsed)	68	A
P <sub>TOT</sub>	Total Dissipation at $T_C = 25^\circ\text{C}$	30	W
	Derating Factor	0.2	W/°C
dv/dt (1)	Peak Diode Recovery voltage slope	7	V/ns
E <sub>AS</sub> (2)	Single Pulse Avalanche Energy	200	mJ
T <sub>stg</sub>	Storage Temperature	-55 to 175	°C
T <sub>j</sub>	Operating Junction Temperature	175	°C

(1)  $I_{SD} \leq 17\text{A}$ ,  $di/dt \leq 300\text{A}/\mu\text{s}$ ,  $V_{DD} \leq V_{(\text{BR})DSS}$ ,  $T_j \leq T_{JMAX}$ .

(2) Starting  $T_j=25^\circ\text{C}$ ,  $I_D=8.5\text{A}$ ,  $V_{DD}=15\text{V}$

(•) Pulse width limited by safe operating area

**Table 4: Thermal Data**

R <sub>thj-case</sub>	Thermal Resistance Junction-case Max	5.0	°C/W
R <sub>thj-amb</sub>	Thermal Resistance Junction-ambient Max	100	°C/W
T <sub>L</sub>	Maximum Lead Temperature For Soldering Purpose	275	°C

### ELECTRICAL CHARACTERISTICS ( $T_{CASE} = 25^\circ\text{C}$ UNLESS OTHERWISE SPECIFIED)

**Table 5: Off**

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
V <sub>(BR)DSS</sub>	Drain-source Breakdown Voltage	$I_D = 250 \mu\text{A}$ , $V_{GS} = 0$	30			V
I <sub>DSS</sub>	Zero Gate Voltage Drain Current ( $V_{GS} = 0$ )	$V_{DS} = \text{Max Rating}$ $V_{DS} = \text{Max Rating}$ , $T_C = 125^\circ\text{C}$			1 10	μA μA
I <sub>GSS</sub>	Gate-body Leakage Current ( $V_{DS} = 0$ )	$V_{GS} = \pm 16\text{V}$			±100	nA

**Table 6: On**

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}$ , $I_D = 250\mu\text{A}$	1	1.5	2.2	V
R <sub>D(on)</sub>	Static Drain-source On Resistance	$V_{GS} = 10\text{V}$ , $I_D = 8.5 \text{ A}$ $V_{GS} = 5 \text{ V}$ , $I_D = 8.5 \text{ A}$		0.038 0.045	0.05 0.06	Ω Ω

**ELECTRICAL CHARACTERISTICS (CONTINUED)****Table 7: Dynamic**

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
$g_{fs}$ (1)	Forward Transconductance	$V_{DS} > I_{D(on)} \times R_{DS(on)max}$ , $I_D = 8.5A$		12		S
$C_{iss}$ $C_{oss}$ $C_{rss}$	Input Capacitance Output Capacitance Reverse Transfer Capacitance	$V_{DS} = 25V$ , $f = 1$ MHz, $V_{GS} = 0$		320 155 28		pF pF pF

**Table 8: Switching On**

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
$t_{d(on)}$ $t_f$	Turn-on Delay Time Rise Time	$V_{DD} = 15V$ , $I_D = 8.5A$ $R_G = 4.7\Omega$ , $V_{GS} = 5V$ (see Figure 16)		11 100		ns ns
$Q_g$ $Q_{gs}$ $Q_{gd}$	Total Gate Charge Gate-Source Charge Gate-Drain Charge	$V_{DD} = 24V$ , $I_D = 17A$ , $V_{GS} = 5V$		4.8 2.25 1.7	6.5	nC nC nC

**Table 9: Switching Off**

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
$t_{d(off)}$ $t_f$	Turn-off-Delay Time Fall Time	$V_{DD} = 15V$ , $I_D = 8.5A$ , $R_G=4.7\Omega$ , $V_{GS} = 5V$ (see Figure 16)		25 22		ns ns
$t_{r(off)}$ $t_f$ $t_c$	Off-voltage Rise Time Fall Time Cross-over Time	$V_{clamp} = 24V$ , $I_D = 17A$ $R_G=4.7\Omega$ , $V_{GS} = 5V$ (see Figure 17)		22 55 75		ns ns ns

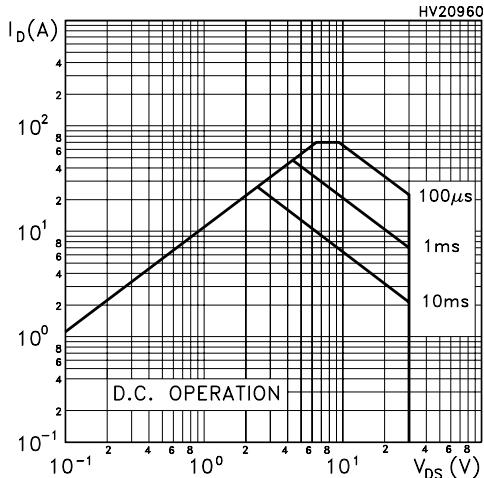
**Table 10: Source Drain Diode**

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
$I_{SD}$	Source-drain Current				22	A
$I_{SDM}$ (2)	Source-drain Current (pulsed)				88	A
$V_{SD}$ (1)	Forward On Voltage	$I_{SD} = 17A$ , $V_{GS} = 0$			1.5	V
$t_{rr}$ $Q_{rr}$ $I_{RRM}$	Reverse Recovery Time Reverse Recovery Charge Reverse Recovery Current	$I_{SD} = 17A$ , $di/dt = 100A/\mu s$ , $V_{DD} = 15V$ , $T_j = 150^\circ C$ (see test circuit, Figure 5)		28 18 1.3		ns nC A

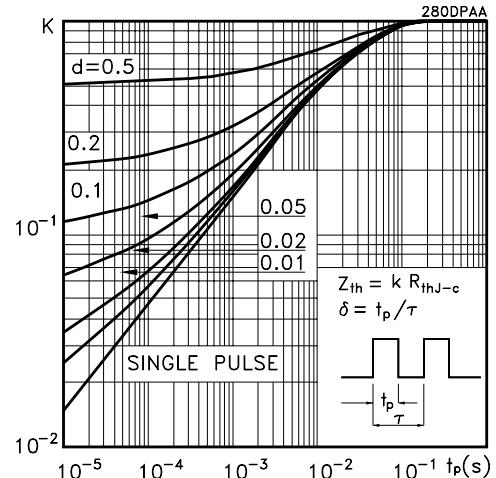
(1) Pulsed: Pulse duration = 300  $\mu s$ , duty cycle 1.5 %.

(2) Pulse width limited by safe operating area.

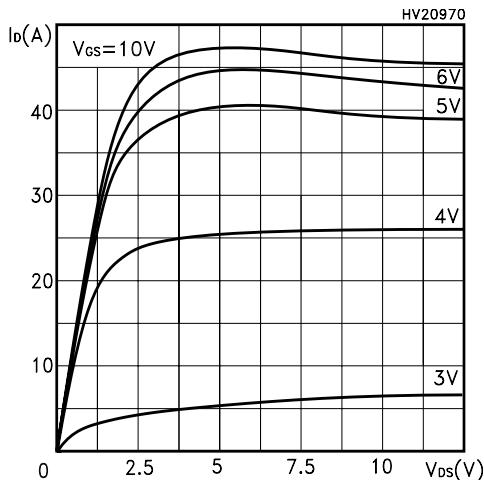
**Figure 3: Safe Operating Area**



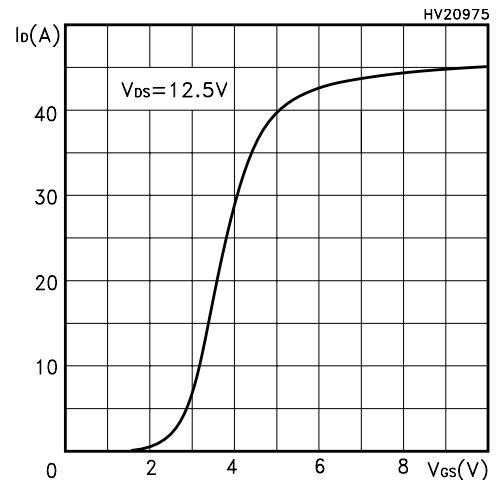
**Figure 6: Thermal Impedance**



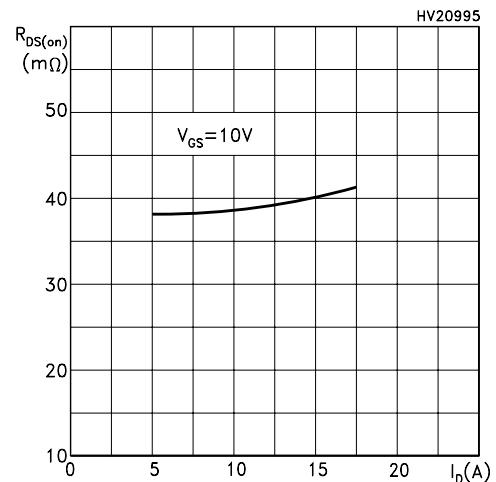
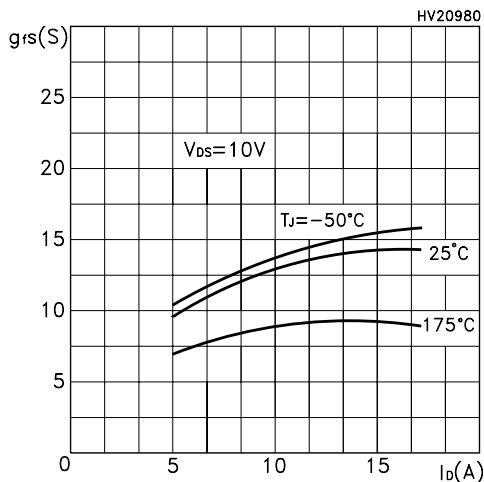
**Figure 4: Output Characteristics**

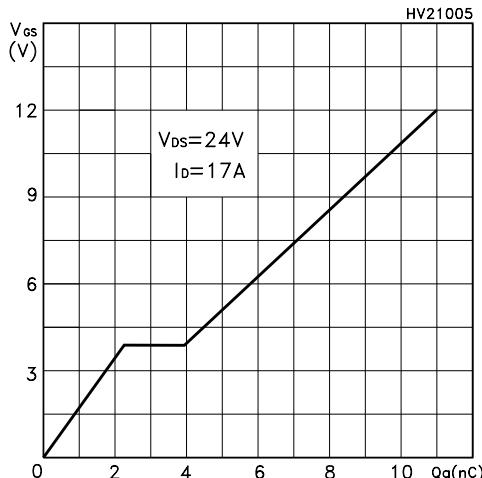
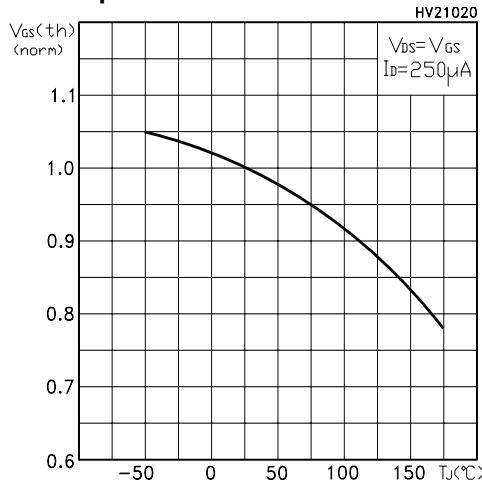
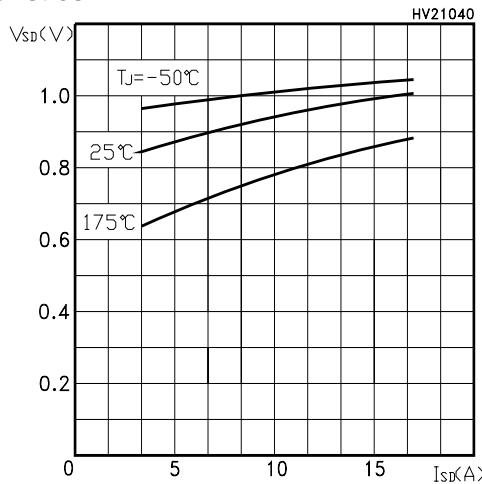
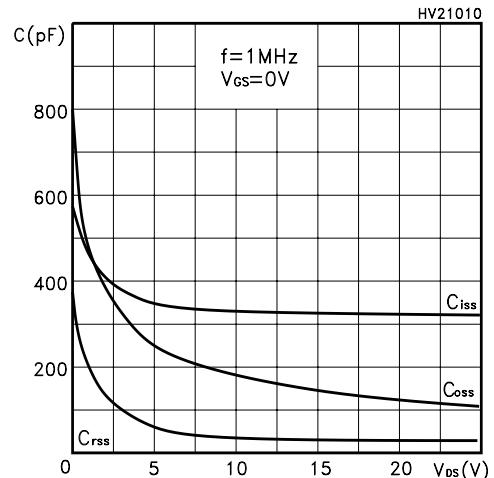
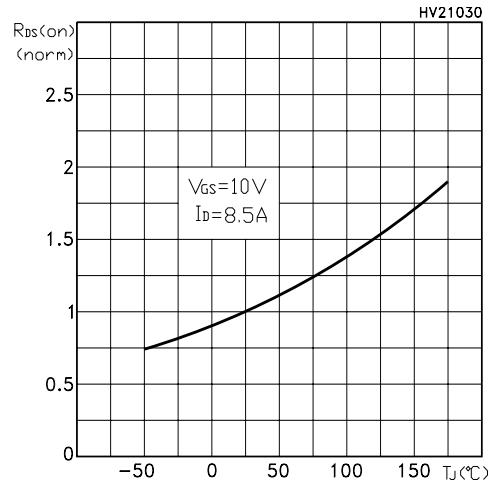
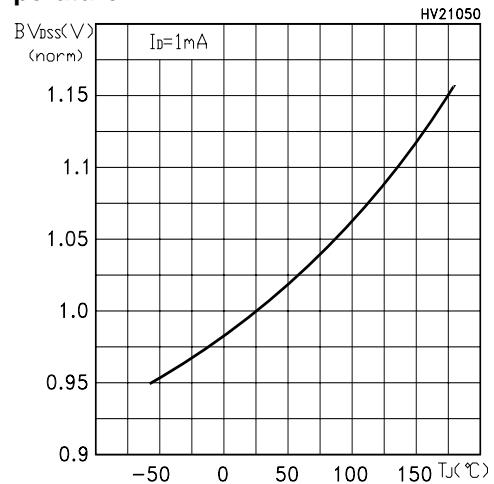


**Figure 5: Transconductance**

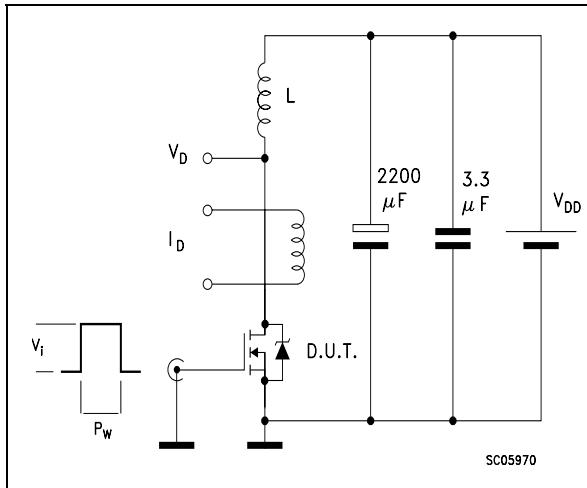


**Figure 8: Static Drain-source On Resistance**



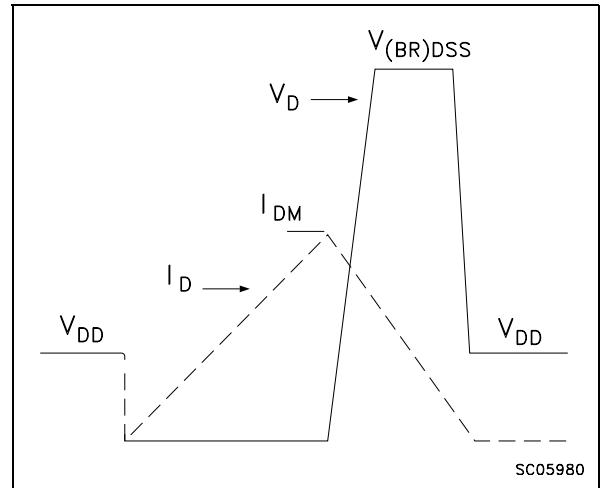
**Figure 9: Gate Charge vs Gate-source Voltage****Figure 10: Normalized Gate Threshold Voltage vs Temperature****Figure 11: Source-Drain Diode Forward Characteristics****Figure 12: Capacitance Variations****Figure 13: Normalized On Resistance vs Temperature****Figure 14: Normalized Breakdown Voltage vs Temperature**

**Figure 15: Unclamped Inductive Load Test Circuit**

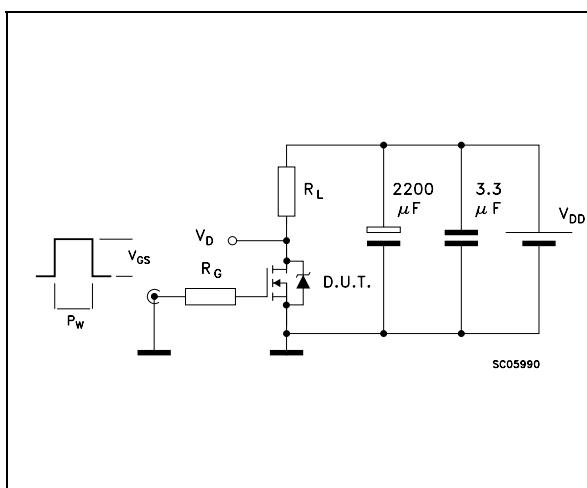


**Figure 16: Switching Times Test Circuit For Resistive Load**

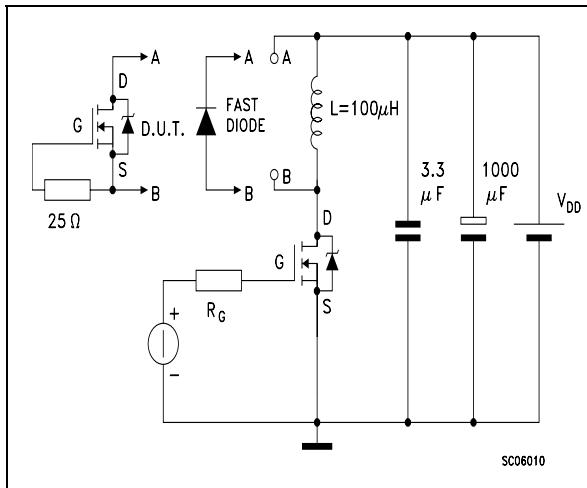
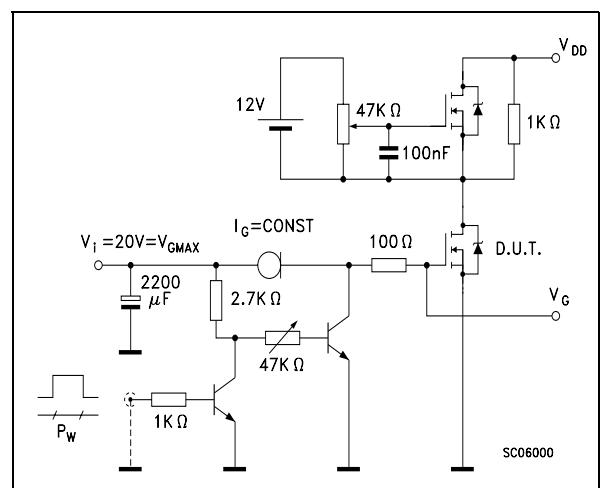
**Figure 18: Unclamped Inductive Waveform**



**Figure 19: Gate Charge Test Circuit**

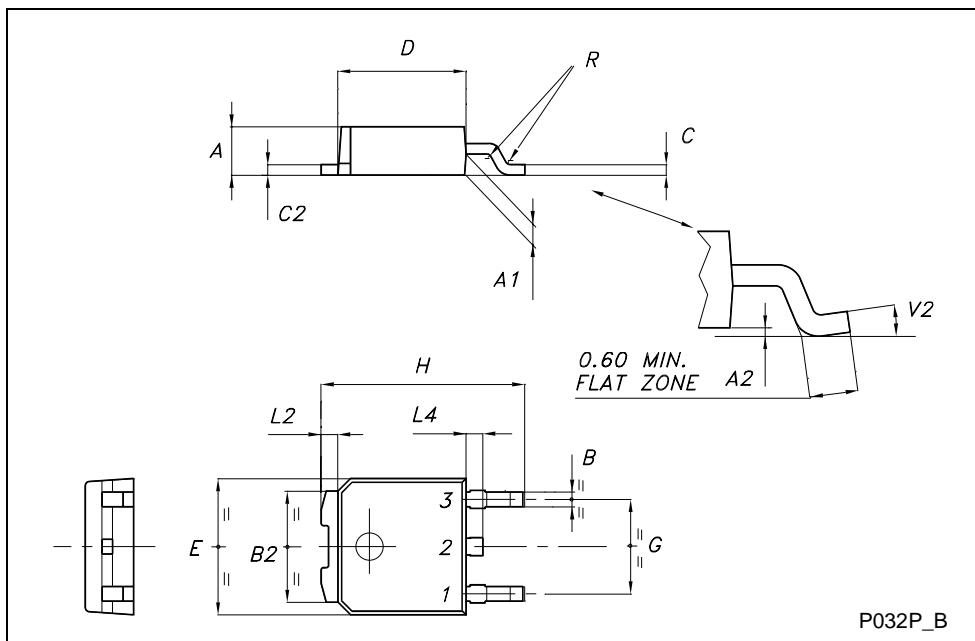


**Figure 17: Test Circuit For Inductive Load Switching and Diode Recovery Times**



## TO-252 (DPAK) MECHANICAL DATA

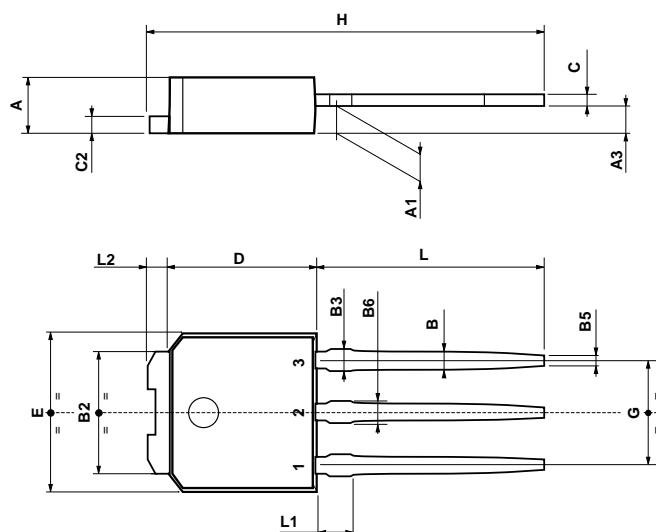
DIM.	mm			inch		
	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
A	2.20		2.40	0.087		0.094
A1	0.90		1.10	0.035		0.043
A2	0.03		0.23	0.001		0.009
B	0.64		0.90	0.025		0.035
B2	5.20		5.40	0.204		0.213
C	0.45		0.60	0.018		0.024
C2	0.48		0.60	0.019		0.024
D	6.00		6.20	0.236		0.244
E	6.40		6.60	0.252		0.260
G	4.40		4.60	0.173		0.181
H	9.35		10.10	0.368		0.398
L2		0.8			0.031	
L4	0.60		1.00	0.024		0.039
V2	0°		8°	0°		0°

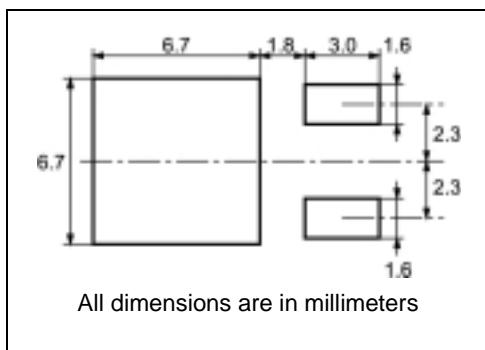
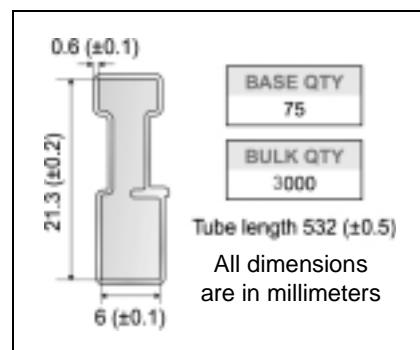
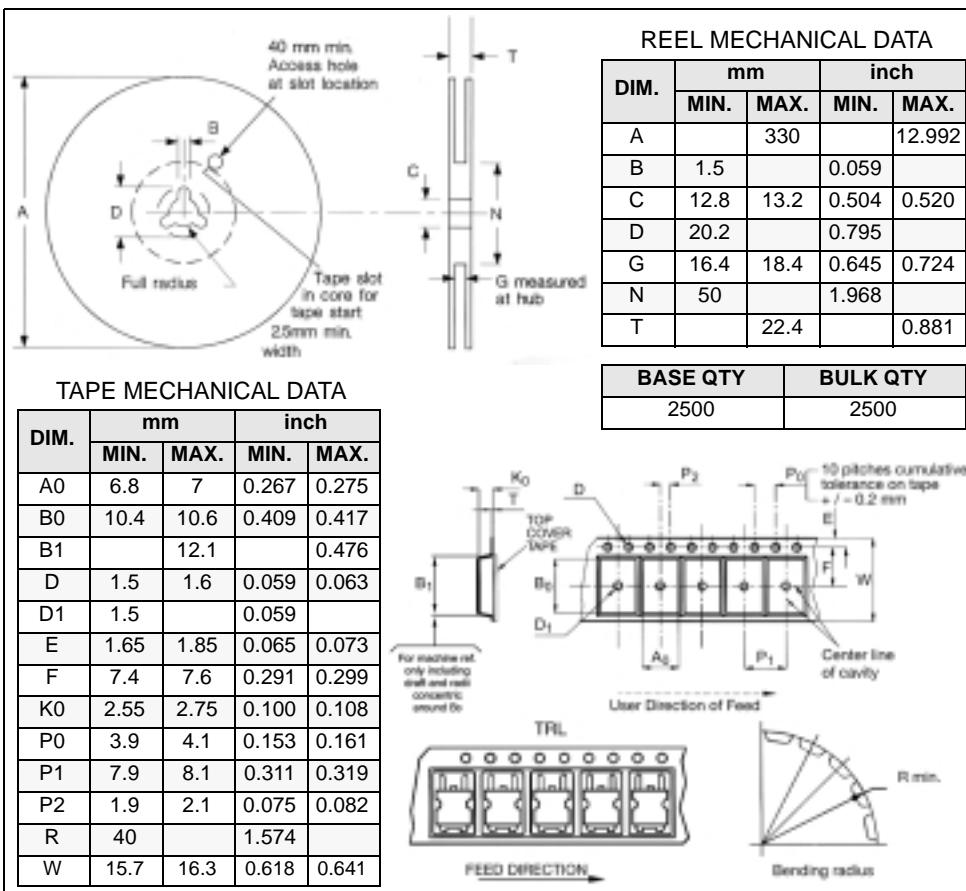


P032P\_B

## TO-251 (IPAK) MECHANICAL DATA

DIM.	mm			inch		
	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
A	2.2		2.4	0.086		0.094
A1	0.9		1.1	0.035		0.043
A3	0.7		1.3	0.027		0.051
B	0.64		0.9	0.025		0.031
B2	5.2		5.4	0.204		0.212
B3			0.85			0.033
B5		0.3			0.012	
B6			0.95			0.037
C	0.45		0.6	0.017		0.023
C2	0.48		0.6	0.019		0.023
D	6		6.2	0.236		0.244
E	6.4		6.6	0.252		0.260
G	4.4		4.6	0.173		0.181
H	15.9		16.3	0.626		0.641
L	9		9.4	0.354		0.370
L1	0.8		1.2	0.031		0.047
L2		0.8	1		0.031	0.039



**DPAK FOOTPRINT****TUBE SHIPMENT (no suffix)\*****TAPE AND REEL SHIPMENT (suffix "T4")\***

\* on sales type

**Table 11: Revision History**

Date	Revision	Description of Changes
08-June-2004	2	New Stylesheet. Datasheet according to PCN DSG-TRA/04/532
19-Oct-2004	3	Modified value in title

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